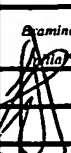




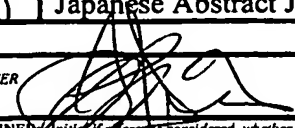
FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	Atty. Docket No. 84885LMB Customer No. 01333	Serial No.
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